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In situ formation of titania film on NiTi alloy treated with hydrogen peroxide solution at low temperature ¹⁰

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Abstract: Chemically polished NiTi shape memory alloy(SMA) substrate was treated with a boiling aqueous solution containing hydrogen peroxide to form titania film in situ at low temperature. The surface characterizations of titania film on NiTi substrate were investigated by scanning electron microscopy, X-ray diffractometry and X-ray photoelectron spectroscopy. The results show that titania film is successfully fabricated in situ on NiTi SMA by this surface oxidation method. It is mainly composed of rutile and anatase, whose surface compositions and morphologies are sensitive to H_2O_2 content. In situ formation mechanism of titania film on NiTi substrate was discussed based on the experimental results.

Key words: titania; thin films; shape memory alloy(SMA); NiTi alloy; oxidation; surface structure

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1 INTRODUCTION

NiTi shape memory alloy (SMA) has been widely used as biomedical applications because of its unique properties, such as shape memory effect and superelastic properties^[1, 2]. It is well known that the biocompatibility of NiTi implants depends on a native corrosion-resistant titania film on the surface of NiTi avoiding the allergic and toxic effects of nickel^[3]. However, nickel either in metallic or oxidized state is also detected on the surface of NiTi, and its amount depends on the surface treatments^[4, 5]. Therefore, it is useful to develop the fabrication approaches of ideal titania film on NiTi SMA, e. g. sol-gel method^[6].

Note the fact that NiTi SMA contains a large amount of Ti, which can be oxidized in the environment containing oxygen and leads to in situ formation of titania. Thus the surface oxidation method may be an ideal process to fabricate titania film for NiTi SMA. Up to now, several high-temperature oxidation methods as well as oxidation behaviors and surface characterizations of NiTi SMA have been reported^[7-11]. It is found that NiTi SMAs after different surface oxidations at high temperatures are predominantly covered with titania, which suggests that in situ formation of times.

tania film on NiTi SMAs by surface oxidation method is possible. It should be pointed out that the phase transformation behaviors in NiTi SMA are very sensitive to the heat treatment conditions, such as temperature^[2]. As a result, the surface oxidation treatment at high temperature will have an undesired effect on shape memory properties of NiTi SMAs.

Many studies indicate that titania films can be successfully synthesized in situ by a low-temperature oxidation of pure Ti substrates in the solutions containing hydrogen peroxide 12-14. However, few systematic literatures have been reported to date to investigate the in situ formation of titania films on the surfaces of NiTi SMAs at low temperature. In the present work, chemically polished NiTi substrates were treated with a boiling aqueous solution containing hydrogen peroxide to form titania film in situ at low temperature.

2 EXPERIMENTAL

A commercially available NiTi (50. 8% Ni, molar fraction, the same below) SMA plate for medical application with a martensite start temperature (M_s) of -12. 8 °C and an austenite finish temperature (A_f) of 33. 4 °C was cut into small rec

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tangular blocks (10 mm × 10 mm × 1 mm). All samples were cleaned separately in acetone, ethanol and deionized water for 10 min, and then chemically polished to remove the original oxides on the surface for 10 min in Kroll's reagent: a mixture of 2 mL hydrofluoric acid (HF, 40%), 4 mL nitric acid (HNO₃, 40%) and 994 mL deionized water. The samples were subsequently ultrasonically washed in acetone for 10 min and in deionized water for 10 min. They were divided into three groups. The first group was used as control. The second group and the third one were further oxidized in the boiling aqueous solutions containing 10% H₂O₂ and 30% H₂O₂ for 2h, respectively, and then ultrasonically rinsed with deionized water for 10 min.

Samples were analyzed by XPS using a VG Scientific ESCALAB 5 spectrometer with monochromatic Al Ka X-ray radiation and 20 eV pass energy. The high-resolution XPS spectra over the Ti 2p, O 1s and Ni 2p ranges were used for assessment of the chemical state as well as for quantification. The phases of the films were characterized by thin-film X-ray diffraction using an X-ray diffractometer (RAD IIA, Rigaku, Japan) operated with Cu Ka under 40 kV and 25 mA, equipped with a thin-film attachment on which the glancing angle was 1°. The surface morphologies of the samples were observed by a Philips XL30 FEG scanning electron microscope (SEM) after the surface was coated with gold films.

RESULTS AND DISCUSSION

Fig. 1 and Fig. 2 show the SEM photographs of the surface of NiTi SMAs. There are some submicron pores on the surface of the chemically polished NiTi SMA, which may be due to the treatment with Kroll's reagent. Oxide films are present on the surfaces of H₂O₂-oxidized NiTi substrates. The surface morphology of the films is sensitive to the concentration of H₂O₂ in the aqueous solutions. The oxide film on the sample treated with the 10% H₂O₂ solution is loose, while the 30% H₂O₂-oxidized NiTi SMA is covered by a homogeneously dense oxide film with some microcracks.

Table 1 lists the chemical compositions of the surfaces of the chemically polished NiTi SMA and the H₂O₂-oxidized NiTi ones, respectively. Ti, Ni and O signals are detected for all samples. The amount of oxygen on the surface of the freshly polished NiTi sample is only about 7.9%, which indicates that the original oxides on the surface of NiTi SMAs have been removed successfully. After NiTi SMA treated by H₂O₂ solution, O becomes the dominant surface element, whose concentration



Fig. 1 SEM image of surface of chemically polished NiTi SMA

Table 1 Chemical composition of surface of NiTi SMAs (molar fraction,

Sample No.	Тi	Ni	0
1	44. 6	47.5	7. 9
2	37. 9	15.3	46. 8
3	34. 9	6.7	58. 4

1 - Chemically polished one; 2 - One treated in the boiling 10% H₂O₂ solutions for 2 h; 3—One treated in boiling 30% H₂O₂ solutions for 2 h

changes with the concentration of H₂O₂ (46. 8% for the 10% H₂O₂-oxidized NiTi and 58. 4% for the 30% H₂O₂-oxidized one). Moreover, the surface concentration of Ni decreases remarkably from 47.5% for the chemically polished sample to 15. 3% for the 10% H_2O_2 -oxidized one and 6. 7% for the 30% H₂O₂-oxidized one.

Fig. 3 shows the high resolution Ti 2p XPS spectra of the surfaces of two H2O2-oxidized NiTi SMAs. Two dominant peaks for both samples are identified as Ti⁴⁺ (TiO₂) 2p_{3/2} at 459.3 eV and Ti^{4+} (TiO_2) $2p_{1/2}$ at 464. 8 eV. Some remnants of combined Ti species (Ti^{NrTi}) in the intermetallic NiTi state can also be found by the presence of the small shoulders near 454. 5 eV and 460. 5 eV on the curves, which correspond to the binding energies of Ti^{NiTi} 2p_{3/2} and 2p_{1/2} spin states^[15].

Fig. 4 shows the high resolution Ni 2p XPS spectra of the surfaces of NiTi SMAs treated in the boiling aqueous solutions containing different concentrations of hydrogen peroxide. They are consistent with each other, and mainly consist of two major peaks. The binding energies of two peaks are about 853. 8 eV and 870. 5 eV, which correspond to Ni^{NrTi} 2p_{3/2} and 2p_{1/2} in the intermetallic NiTi state rather than free Ni(Ni⁰ 2p_{3/2} of 853.0 eV) [15]. The Ni oxide peak could not be found for both samples. Moreover, Ni^{NiTi} 2p spec tra exhibit an additional satellite structure, which

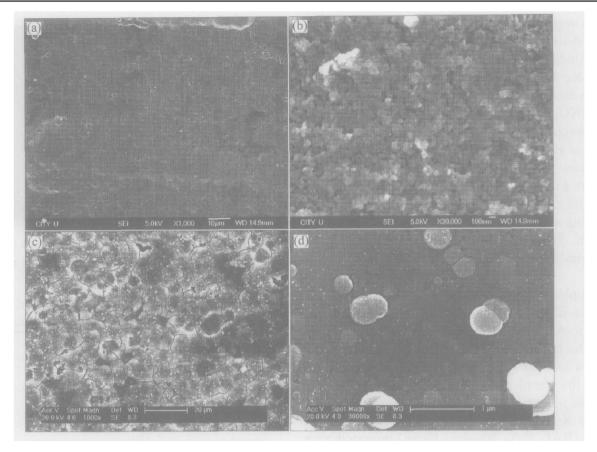


Fig. 2 SEM images of surface of NiTi SMAs treated in boiling aqueous solutions containing different concentrations of hydrogen peroxide for 2 h

(a) -10% H₂O₂; (b) -High magnification of (a); (c) -30% H₂O₂; (d) -High magnification of (c)

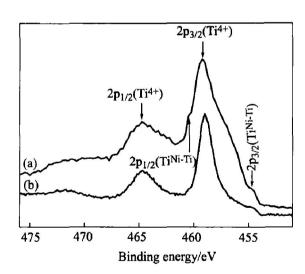


Fig. 3 Ti 2p XPS spectra of surface of NiTi SMAs treated in boiling aqueous solutions containing different concentrations of hydrogen peroxide for 2 h
(a) -10% H₂O₂; (b) -30% H₂O₂

is separated from the main peaks by $7\,\mathrm{eV}$ as shown in Fig. 4. This additional satellite structure coincides with that observed in NiTi samples in the literature $^{[4]}$.

Fig. 5 shows the XRD patterns of the surfaces of NiTi SMAs treated in the boiling aqueous solu-

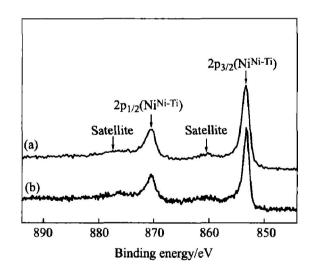


Fig. 4 Ni 2p XPS spectra of surface of NiTi SMAs treated in boiling aqueous solutions containing different concentrations of hydrogen peroxide for 2 h
(a) -10% H₂O₂; (b) -30% H₂O₂

tions containing different concentrations of hydrogen peroxide. It can be found that except for the peak of the crystal plane (110) corresponding to intermetallic NiTi substrate phase, the broad peaks associated with the crystal planes (110) and (101) of rutile and the crystal plane (101) of anatase are present for both samples. Obviously the

XRD patterns display a consistent result with the XPS spectra that a titania film mainly consists of poorly crystallized rutile and anatase phases formed on the H₂O₂-oxidized NiTi SMA. Both Ni oxide and free Ni could not be detected from XRD and XPS spectra, thus the remnant Ni in titania films must be presented as intermetallic NiTi phase, which has also been indicated by XPS analysis. The XRD peak corresponding to intermetallic NiTi phase in Fig. 5 may derive from both the remnant NiTi phase in the titania film and the NiTi substrate.

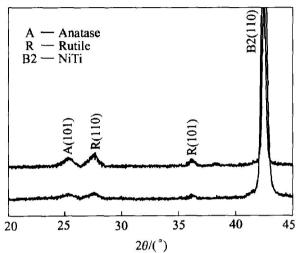


Fig. 5 XRD patterns of surface of NiTi SMAs treated in boiling aqueous solutions containing different concentrations of hydrogen peroxide for 2 h (a) -10% H₂O₂; (b) -30% H₂O₂

In situ formation mechanism of titania films on NiTi substrates in the boiling H₂O₂ aqueous solution was proposed as follows based on our experimental results. As discussed in the literature [15], most metals react with oxygen at surface imperfections to form an oxide layer with a release of free energy. In this study, the oxidizing reaction of Ni-Ti SMA proceeds by the decomposition of H₂O₂ into oxygen. It is estimated that the enthalpy of TiO₂ formation (- 956 kJ/mol) is almost four times of the one for NiO formation (- 241 kJ/ mol) [16], which may reflect the stronger affinity of Ti than that of Ni for oxygen chemisorption. Therefore, Ti on the outermost surface of NiTi is oxidized firstly by oxygen derived from the decomposition of H₂O₂ to form TiO₂ while Ni remains unchanged. Ni atoms can be removed from the Nr Ti bond due to H₂O₂-etching, left from the surface and are released into the aqueous solution during boiling, while Ti bound in oxide is more stable and not released into the aqueous solution. The release of Ni atoms from NiTi surface into the boiling water has already been found by Shabalovskaya and Anderegg with the aid of inductively coupled plasma analysis (ICPA)^[4]. The release of Ni atoms leads to the formation of vacancies on NiTi substrate, which can promote the further reaction of oxygen with Ti atoms. The predominant phase TiO2 in the oxide film has a larger unit cell volume (0. 062 nm³ for rutile) than austenitic NiTi substrate (0. 027 nm³)^[15]. The larger TiO₂ crystal structure is accommodated by O migration towards the NiTi substrate and Ni migration towards the surface. As the oxidation progresses, O atoms diffuse inward while Ni atoms diffuse outward through the oxide film. Finally, the oxide film mainly comprised TiO₂ and depleted relatively in Ni forms on NiTi substrate. Obviously in situ formation of titania film on NiTi substrates in the boiling H₂O₂ aqueous solution is dominated by in situ oxidation of surface component Ti and the synchronous removal of undesired Ni into the aqueous solution. The growth rate of titania film is mainly controlled by the diffusion process of O and Ni atoms in titania film. Owing to the volume difference between the oxide and NiTi substrate, high stress will be built up in titania film, especially in dense titania film during its growing process. As a result, some microcracks form in titania film on the H₂O₂-oxidized NiTi SMA, as shown in Fig. 2.

Although the surface concentration of Ni could decrease remarkably to 6.7% after NiTi was oxidized by 30% H₂O₂ solution, the remnant Ni in titania film is undesired and must be removed as greatly as possible. The remnant of Ni presented as NiTi phase in titania film may be due to the insufficient oxidation reaction of NiTi substrate and the incomplete removal of Ni into the aqueous solution under the given conditions, which is associated with the relatively low reactivity ability of Ti with O and the relatively low diffusion rate of O and Ni atoms at low temperature. The formation of titania films with different surface morphologies and compositions as shown in Fig. 2 may be related with different oxidation abilities of the boiling aqueous solutions containing different concentrations of H₂O₂. Moreover, the crystalline of titania films on two H₂O₂-oxidized NiTi SMAs is poor and needs to be improved. The optimized techniques to fabricate ideal titania films on NiTi substrates using this low-temperature oxidation method will be reported in the future.

CONCLUSIONS

Titania film is successfully fabricated in situ on NiTi SMA by surface oxidation in a boiling H₂O₂ aqueous solution at low temperature. Titania film is mainly composed of rutile and anatase, whose surface compositions and morphologies are sensitive to H₂O₂ content in the aqueous solution.

In situ formation of titania film on NiTi substrate is dominated by in situ oxidation of surface component Ti and the synchronous removal of undesired Ni into the aqueous solution.

REFERENCES

- [1] Duerig T, Pelton A, Stockel D. An overview of nitinol medical applications [J]. Mater Sci Eng, 1999, A273 275: 149 160.
- [2] Otsuka K, Wayman C M. Shape Memory Materials [M]. Cambridge: Cambridge University Press, 1998.
- [3] Wever D J, Veldhuizen A G, Vries J D E, et al. Electrochemical and surface characterization of a nickel-titanium alloy [J]. Biomaterials, 1998, 19: 761-769.
- [4] Shabalovskaya S A, Anderegg J W. Surface spectroscopic characterization of TiNi nearly equiatomic shape memory alloys for implants [J]. J Vac Sci Technol, 1995, A13(5): 2624-2632.
- [5] Filip P, Lausmaa J, Musialek J, et al. Structure and surface of TiNi human implants [J]. Biomaterials, 2001, 22: 2131-2138.
- [6] LIU J X, YANG D Z, SHI F, et al. Sol-gel deposited TiO₂ film on NiTi surgical alloy for biocompatibility improvement [J]. Thin Solid Films, 2003, 429 (1 -2): 225-230.
- [7] Armitag D A, Grant D M. Characterisation of surface modified nickel titanium alloys [J]. Mater Sci Eng, 2003, A349: 89-97.
- [8] Firstov G S, Vitchev R G, Kumar H, et al. Surface

- oxidation of NiTi shape memory alloy [J]. Biomaterials, 2002, 23: 4863 4871.
- [9] XU C H, MA X Q, SHI S Q, et al. Oxidation behavior of TiNi shape memory alloy at 450 750 °C [J]. Mater Sci Eng. 2004, A371: 45 50.
- [10] CHU C L, WU S K, YEN Y C. Oxidation behavior of equiatomic TiNi alloy in high temperature air environment [J]. Mater Sci Eng, 1996, A216: 193 200.
- [11] Chan C M, Trigwell S, Duerig T. Oxidation of a Ni-Ti alloy [J]. Surf Interface Anal, 1990, 15: 349 -354.
- [12] Takemoto S, Yamamoto T, Tsuru K, et al. Platelet adhesion on titanium oxide gels: effect of surface oxidation [J]. Biomaterials, 2004, 25: 3485 3492.
- [13] WU J, Hayakawa S, Tsuru K, et al. Porous titania films prepared from interactions of titanium with hydrogen peroxide solution [J]. Scripta Materialia, 2002, 46: 101 106.
- [14] WANG X X, Hayakawa S, Tsuru K, et al. Improvement of bioactivity of H₂O₂/TaCl5-treated titanium after subsequent heat treatments [J]. J Biomed Mater Res, 2000, 52: 171 176.
- [15] Green S M, Grant D M, Wood J V. XPS characterization of surface modified NrTi shape memory alloy [J]. Mater Sci Eng, 1997, A224: 21-26.
- [16] Weast R C, Astle M J. CRC Handbook of Chemistry and Physics [M]. Florida: CRC Press, 1982.

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